



MJ P-Channel Enhancement Mode Power MOSFET

Description

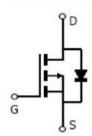
The MJ55P15K uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

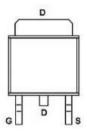
- $V_{DS} = -55V, I_{D} = -15A$ $R_{DS(ON)} < 75mΩ @ V_{GS} = -10V$
- ◆ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Excellent package for good heat dissipation

Application

- ◆ Power switch
- ◆ Load switch in high current applications
- ◆ DC/DC converters







Marking and pin assignment



TO-252-2L top view

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ55P15K	MJ55P15K	TO-252-2L	ii ii	-	2

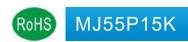
Absolute Maximum Ratings (Tc =25 °Cunless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vos	-55	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	lo	-15	Α
Drain Current-Continuous(Tc =100°C)	ID(100°C)	-10	Α
Pulsed Drain Current	Ідм	-50	Α
Maximum Power Dissipation	Po	35	W
Operating Junction and Storage Temperature Range	Тл ,Тѕтс	-55 To 150	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	Rejc	4.3	°C/W





Electrical Characteristics (Tc =25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Uni
Off Characteristics	'					
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V I _D =-250µA	-55	_	_	V
Zero Gate Voltage Drain Current	Ipss	V _{DS} =-55V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	lgss	V _{DS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	Vos=Vgs ,Io=-250µA	-1.5	-2.6	-3.5	V
Drain-Source On-State Resistance	RDS(ON)	V _{GS} =-10V, I _D =-5A	_	60	75	mΩ
Forward Transconductance	g FS	V _{DS} =-15V,I _D =-5A	16	_	-	S
Dynamic Characteristics (Note 4)						
Input Capacitance	Clss		-	1450	-	PF
Output Capacitance	Coss	V _{DS} =-20V,V _{GS} =0V F=1.0MHz	-	145	-	PF
Reverse Transfer Capacitance	Crss		-	110	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	8	-	nS
Turn-on Rise Time	tr	V _{DD} =-30V,R _L =30Ω	-	9	-	nS
Turn-Off Delay Time	t _{d(off)}	Vgs=-10V,Rgen=6Ω	-	65	-	nS
Turn-Off Fall Time	t f	•	-	30	-	nS
Total Gate Charge	Q_9		_	26	-	nC
Gate-Source Charge	Qgs	V _{DS} =-30V,I _D =-5A V _{GS} =-10V	-	4.5	-	nC
Gate-Drain Charge	Q _{gd}		-	7	-	nC
Drain-Source Diode Characteristics		I	<u> </u>	I	I	
Diode Forward Voltage (Note 3)	VsD	V _{GS} =0V,I _S =-15A	_	-	1.2	V
Diode Forward Current (Note 2)	Is		_	_	-15	А

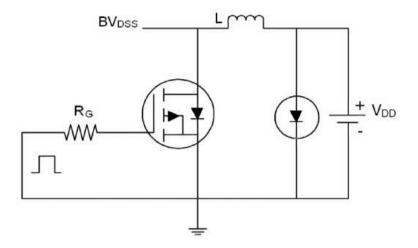
Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- Surface Mounted on FR4 Board, t ≤ 10 sec.
- $\cent{3}$ Pulse Test: Pulse Width $\leq 300 \mu s$, Duty Cycle $\leq 2\%$.
- 4 Guaranteed by design, not subject to production

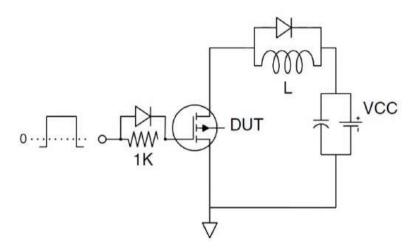




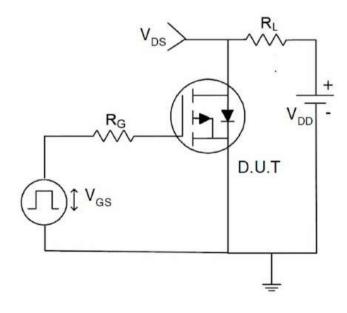
Test circuit



Eas test Circuit



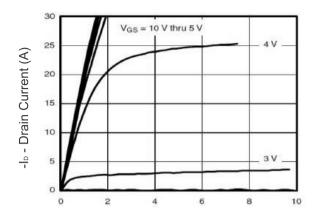
Gate charge test Circuit



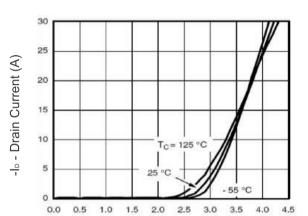
Switch Time Test Circuit



Typical Electrical and Thermal Characteristics (Curves)



-Vds Drain-Source Voltage (V) Figure 1 Output Characteristics



-Vgs Gate-Source Voltage (V) Figure 2 Transfer Characteristics

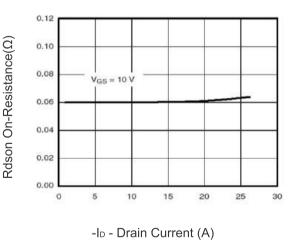
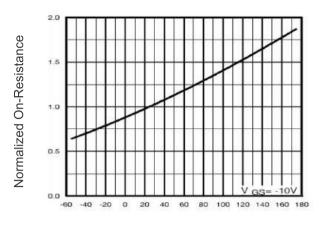
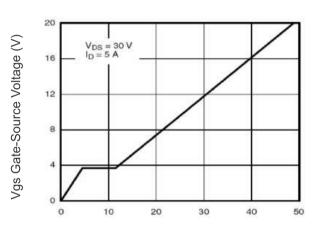


Figure 3 Rdson- Drain Current

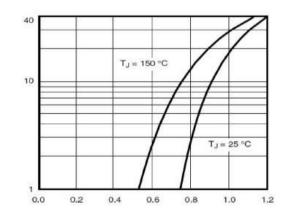


T_J -Junction Temperature(°C)

Figure 4 Rdson-Junction Temperature



Qg Gate Charge (nC) Figure 5 Gate Charge

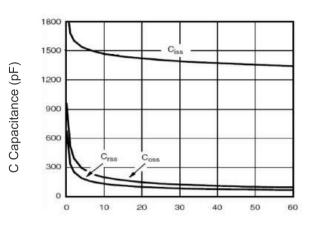


Vsd Source-Drain Voltage (V)

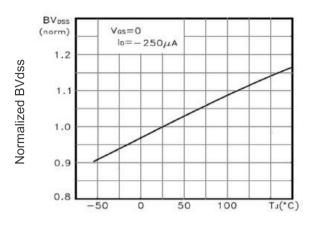
Figure 6 Source- Drain Diode Forward

Is - Reverse Drain Current (A)

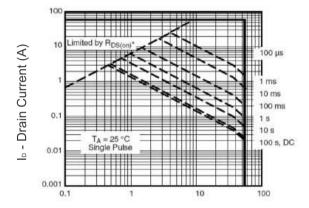




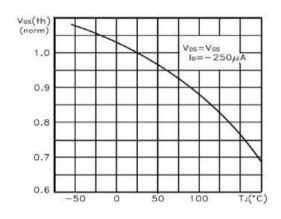
Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



TJ -Junction Temperature(°C)
Figure 9 BVpss vs Junction Temperature

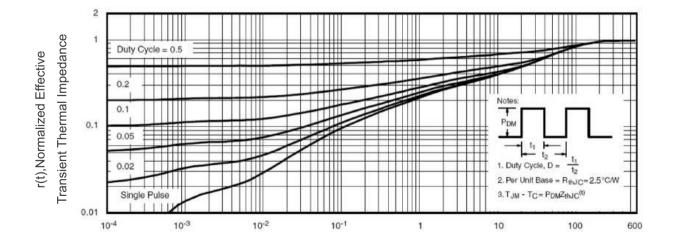


Vds Drain-Source Voltage (V)
Figure 8 Safe Operation Area



T_J -Junction Temperature(°C)

Figure 10 V_{GS(th)} vs Junction Temperature



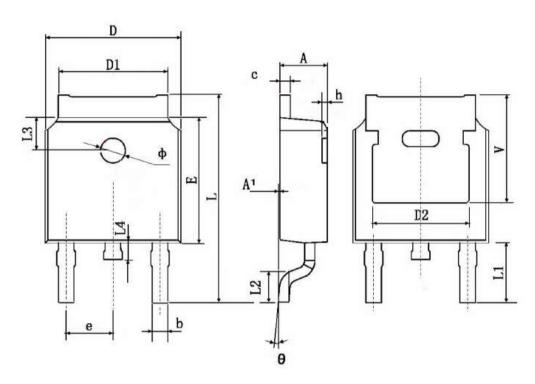
Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance





TO-252 Package Information



Cumulant	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.8	30 TYP.	0.190 TYP.	
E	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900	TYP.	0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0.	8°
h	0.000	0.300	0.000	0.012
V	5.350	5.350 TYP.		TYP.





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